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Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				<b>Complete if Known</b>	
				Application Number	Not Yet Assigned
				Filing Date	Concurrently Herewith
				First Named Inventor	Yue Ma
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
				Attorney Docket Number	9432-000246/US/NPB
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
AC	AA*	US-20020191816-A1	12-19-2002	Maritzen et al.	
AC	AB*	US-5,341,226-A	08-23-1994	Shiau	
AC	AC*	US-20030035580-A1	02-20-2003	Wang et al.	
AC	AD*	US-20030122942-A1	07-03-2003	Parker et al.	
AC	AE*	US-20020114535-A1	08-22-2002	Luo	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
AC	CA	PORTER et al. A Robust Automatic Clustering Scheme for Image Segmentation Using Wavelets, IEEE Transactions on Image Processing, April 1996, Vol. 5, Issue 4, pages 662-665		

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Examiner Signature	/Aaron Carter/	Date Considered	12/13/2006
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